



SEMITRANS® 2

## V Series IGBT Module

### SKM200GAL12VL2

#### Features\*

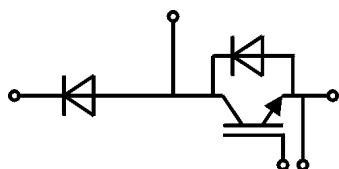
- V-IGBT = 6. Generation Trench V-IGBT (Fuji)
- CAL4 = Soft switching 4. Generation CAL-diode
- Insulated copper baseplate using DBC technology (Direct Bonded Copper)
- Increased power cycling capability
- With integrated gate resistor
- UL recognized, file no. E63532
- Lowest switching losses at High di/dt

#### Typical Applications

- Electronic welders
- DC/DC – converter
- Brake chopper
- Switched reluctance motor

#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
- Recommended  $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for  $T_j = 150^\circ\text{C}$



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#### Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT				
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		1200	V
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	299	A
		T <sub>c</sub> = 80 °C	228	A
I <sub>Cnom</sub>			200	A
I <sub>CRM</sub>			600	A
V <sub>GES</sub>			-20 ... 20	V
t <sub>psc</sub>	V <sub>CC</sub> = 720 V V <sub>GE</sub> ≤ 15 V V <sub>CES</sub> ≤ 1200 V	T <sub>j</sub> = 125 °C	10	μs
T <sub>j</sub>			-40 ... 175	°C

#### Inverse diode

V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		1200	V
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	189	A
		T <sub>c</sub> = 80 °C	141	A
I <sub>FRM</sub>			450	A
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C		900	A
T <sub>j</sub>			-40 ... 175	°C

#### Freewheeling diode

V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		1200	V
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	229	A
		T <sub>c</sub> = 80 °C	172	A
I <sub>FRM</sub>			600	A
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C		990	A
T <sub>j</sub>			-40 ... 175	°C

#### Module

$I_{t(RMS)}$		200	A
$T_{stg}$	module without TIM	-40 ... 125	$^\circ\text{C}$
$V_{isol}$	AC sinus 50 Hz, $t = 1\text{ min}$	4000	V

#### Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
<b>IGBT</b>					
$V_{CE(sat)}$	$I_C = 200\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.86	2.30	V
		$T_j = 150^\circ\text{C}$	2.20	2.66	V
$V_{CE0}$	chipelevel	$T_j = 25^\circ\text{C}$	0.94	1.07	V
		$T_j = 150^\circ\text{C}$	0.88	0.98	V
$r_{CE}$	$V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	4.6	6.2	$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	6.6	8.4	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 8\text{ mA}$	5.5	6	6.5	V
$I_{CES}$	$V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}, T_j = 25^\circ\text{C}$			0.3	mA
$C_{ies}$	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	12.0		nF
$C_{oes}$		$f = 1\text{ MHz}$	1.18		nF
$C_{res}$		$f = 1\text{ MHz}$	1.18		nF
$Q_G$	$V_{GE} = -8\text{ V} \dots +15\text{ V}$		2210		nC
$R_{Gint}$	$T_j = 25^\circ\text{C}$		3.8		$\Omega$



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- Increased power cycling capability
- With integrated gate resistor
- UL recognized, file no. E63532
- Lowest switching losses at High di/dt

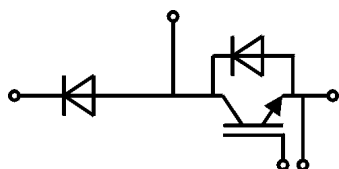
#### Typical Applications

- Electronic welders
- DC/DC – converter
- Brake chopper
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#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
- Recommended  $T_{op} = -40 \dots +150^\circ\text{C}$
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
t <sub>d(on)</sub>	V <sub>CC</sub> = 600 V	T <sub>j</sub> = 150 °C		305		ns
t <sub>r</sub>	I <sub>C</sub> = 200 A	T <sub>j</sub> = 150 °C		51		ns
E <sub>on</sub>	V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		24		mJ
t <sub>d(off)</sub>	R <sub>G on</sub> = 1 Ω	T <sub>j</sub> = 150 °C		493		ns
t <sub>f</sub>	R <sub>G off</sub> = 1 Ω	T <sub>j</sub> = 150 °C		88		ns
E <sub>off</sub>	di/dt <sub>on</sub> = 4500 A/μs di/dt <sub>off</sub> = 2060 A/μs dv/dt = 5400 V/μs	T <sub>j</sub> = 150 °C		22		mJ
R <sub>th(j-c)</sub>	per IGBT				0.14	K/W
R <sub>th(c-s)</sub>	per IGBT (λ <sub>grease</sub> =0.81 W/(m*K))			0.056		K/W
R <sub>th(c-s)</sub>	per IGBT, pre-applied phase change material			0.038		K/W
Inverse diode						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 150 A	T <sub>j</sub> = 25 °C		2.14	2.46	V
	V <sub>GE</sub> = 0 V chiplevel	T <sub>j</sub> = 150 °C		2.04	2.38	V
V <sub>F0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.30	1.50	V
		T <sub>j</sub> = 150 °C		0.90	1.10	V
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		5.6	6.4	mΩ
		T <sub>j</sub> = 150 °C		7.6	8.7	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 150 A	T <sub>j</sub> = 150 °C		92		A
Q <sub>rr</sub>	di/dt <sub>off</sub> = 2250 A/μs	T <sub>j</sub> = 150 °C		25		μC
E <sub>rr</sub>	V <sub>GE</sub> = -15 V V <sub>CC</sub> = 600 V	T <sub>j</sub> = 150 °C		8.5		mJ
R <sub>th(j-c)</sub>	per diode				0.31	K/W
R <sub>th(c-s)</sub>	per diode (λ <sub>grease</sub> =0.81 W/(m*K))			0.07		K/W
R <sub>th(c-s)</sub>	per diode, pre-applied phase change material			0.063		K/W
Freewheeling diode						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 200 A	T <sub>j</sub> = 25 °C		2.20	2.52	V
	V <sub>GE</sub> = 0 V chiplevel	T <sub>j</sub> = 150 °C		2.16	2.47	V
V <sub>F0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.30	1.50	V
		T <sub>j</sub> = 150 °C		0.90	1.10	V
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		4.5	5.1	mΩ
		T <sub>j</sub> = 150 °C		6.3	6.9	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 200 A	T <sub>j</sub> = 150 °C		170		A
Q <sub>rr</sub>	di/dt <sub>off</sub> = 3950 A/μs	T <sub>j</sub> = 150 °C		33		μC
E <sub>rr</sub>	V <sub>GE</sub> = -15 V V <sub>CC</sub> = 600 V	T <sub>j</sub> = 150 °C		13		mJ
R <sub>th(j-c)</sub>	per diode				0.26	K/W
R <sub>th(c-s)</sub>	per diode (λ <sub>grease</sub> =0.81 W/(m*K))			0.068		K/W
R <sub>th(c-s)</sub>	per diode, pre-applied phase change material			0.061		K/W



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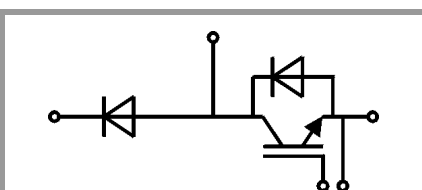
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Module						
L <sub>CE</sub>			30			nH
R <sub>CC'+EE'</sub>	measured per switch	T <sub>C</sub> = 25 °C	0.65			mΩ
		T <sub>C</sub> = 125 °C	1.09			mΩ
R <sub>th(c-s)1</sub>	calculated without thermal coupling (λ <sub>grease</sub> =0.81 W/(m*K))		0.0311			K/W
R <sub>th(c-s)2</sub>	including thermal coupling, T <sub>s</sub> underneath module (λ <sub>grease</sub> =0.81 W/(m*K))		0.034			K/W
R <sub>th(c-s)2</sub>	including thermal coupling, T <sub>s</sub> underneath module, pre-applied phase change material		0.026			K/W
M <sub>s</sub>	to heat sink M6		3		5	Nm
M <sub>t</sub>		to terminals M5	2.5		5	Nm
						Nm
w			160			g



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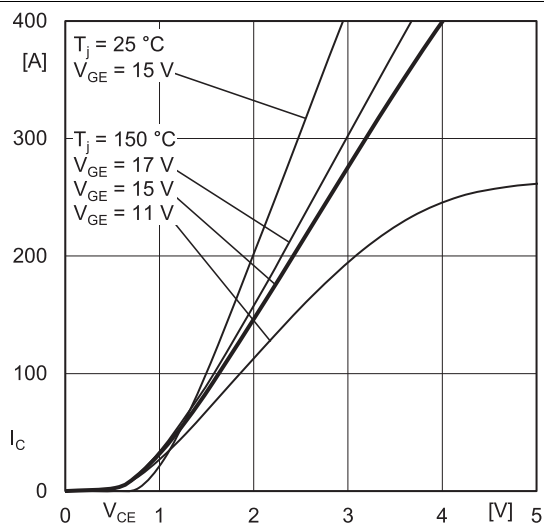


Fig. 1: Typ. output characteristic, inclusive  $R_{CC'+EE'}$

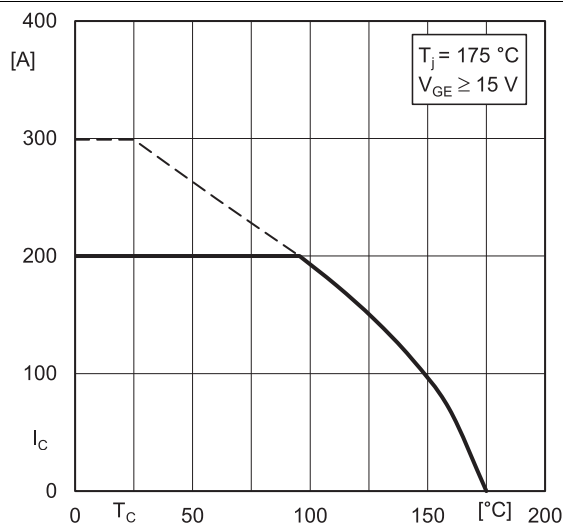


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

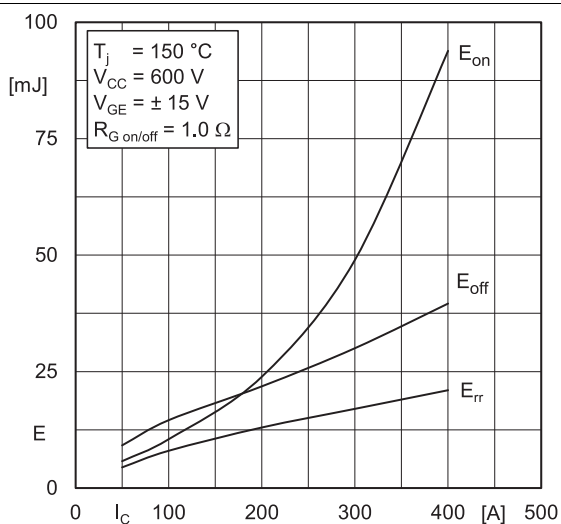


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

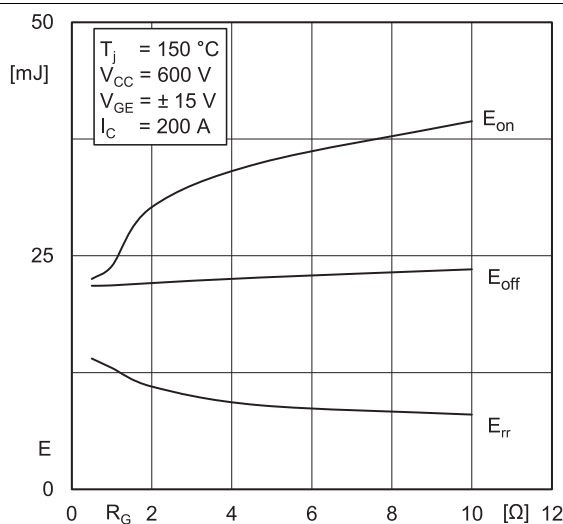


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

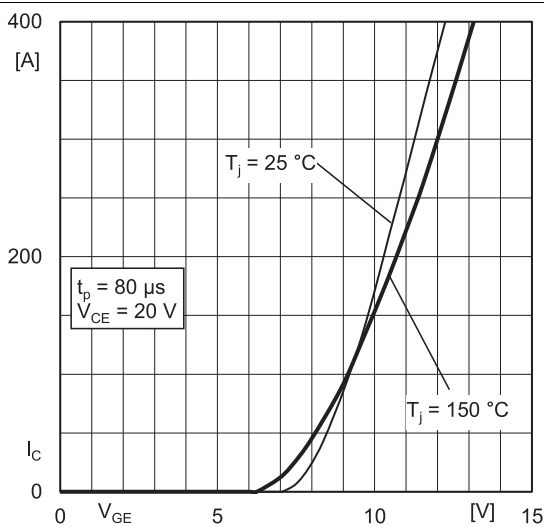


Fig. 5: Typ. transfer characteristic

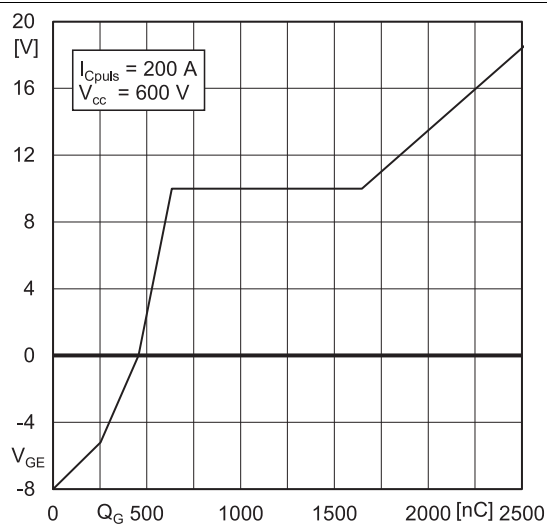
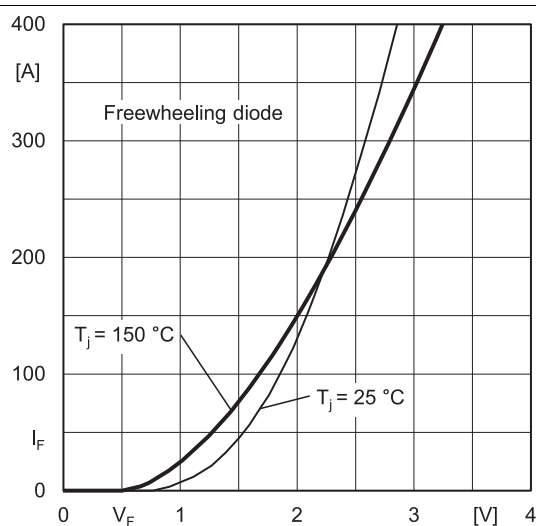
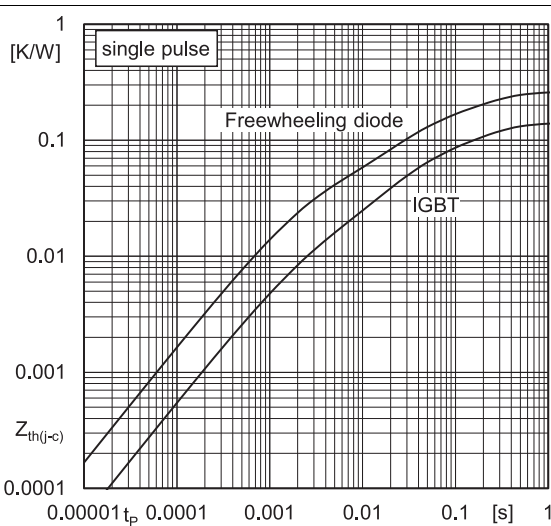
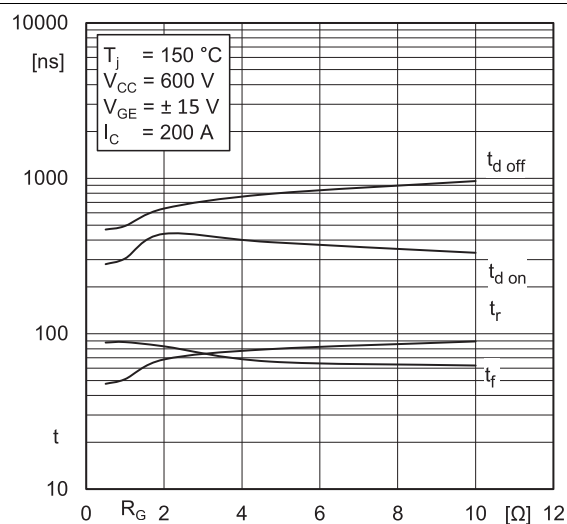
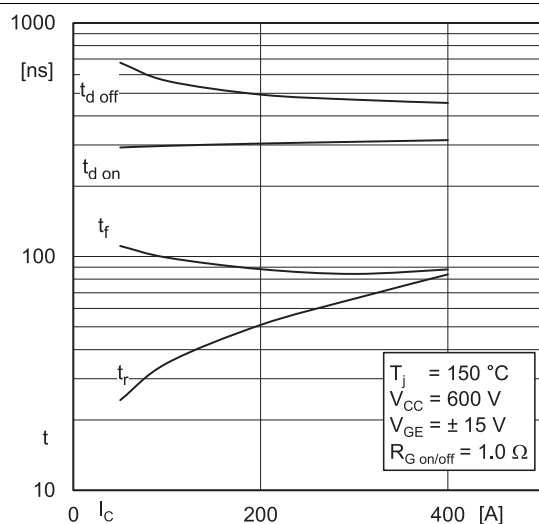


Fig. 6: Typ. gate charge characteristic





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

## **\*IMPORTANT INFORMATION AND WARNINGS**

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